Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/974,554	LINDQVIST ET AL.
Examiner	Art Unit

Ellen C. Tran

2134

SEARCHED					
	SEARCHED				
Class	Subclass	Date	Examiner		
713	162	4/27/2007	ECT		
384	14	4/27/2007	ECT		
381	311	4/27/2007	ECT		
455	3	4/27/2007	ECT		
	-	·			
			1		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	·			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	4/27/2007	ECT	
NPL - IEEE XPLORE / GOOGLE	4/27/2007	ECT	
All claims were reviewed for possible 101 rejections	4/27/2007	ECT	